

MITSUBISHI IGBT MODULES  
**CM600DU-24F**

HIGH POWER SWITCHING USE

**CM600DU-24F**



- IC ..... 600A
- VCES ..... 1200V
- Insulated Type
- 2-elements in a pack

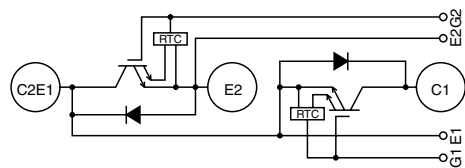
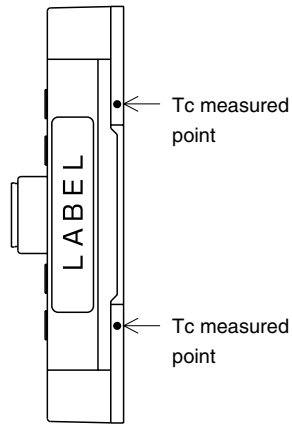
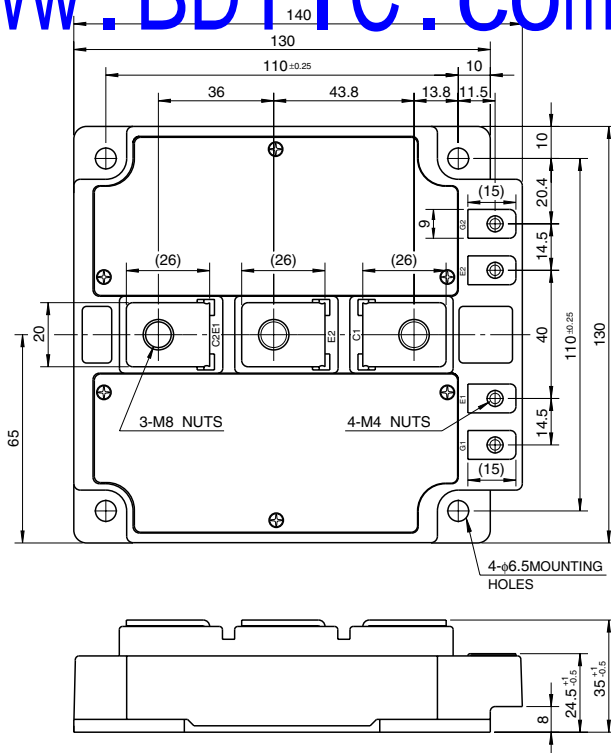
**APPLICATION**

General purpose inverters & Servo controllers, etc

**OUTLINE DRAWING & CIRCUIT DIAGRAM**

Dimensions in mm

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CIRCUIT DIAGRAM

MAXIMUM RATINGS (T<sub>j</sub> = 25°C)

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CE</sub> S	Collector-emitter voltage	G-E Short	1200	V
V <sub>GE</sub> S	Gate-emitter voltage	C-E Short	±20	V
I <sub>C</sub>	Collector current	T <sub>c</sub> = 25°C	600	A
I <sub>CM</sub>		Pulse (Note 2)	1200	A
I <sub>E</sub> (Note 1)	Emitter current	T <sub>c</sub> = 25°C	600	A
I <sub>EM</sub> (Note 1)		Pulse (Note 2)	1200	A
P <sub>C</sub> (Note 3)	Maximum collector dissipation	T <sub>c</sub> = 25°C	1540	W
T <sub>j</sub>	Junction temperature		-40 ~ +150	°C
T <sub>stg</sub>	Storage temperature		-40 ~ +125	°C
V <sub>iso</sub>	Isolation voltage	Main terminal to base plate, AC 1 min.	2500	V
—	Torque strength	Main Terminal M8	8.8 ~ 10.8	N • m
		Mounting holes M6	3.5 ~ 4.5	
		G(E) Terminal M4	1.3 ~ 1.7	
—	Weight	Typical value	1200	g

ELECTRICAL CHARACTERISTICS (T<sub>j</sub> = 25°C)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
I <sub>CE</sub> S	Collector cutoff current	V <sub>CE</sub> = V <sub>CE</sub> S, V <sub>GE</sub> = 0V	—	—	2	mA
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	I <sub>C</sub> = 60mA, V <sub>CE</sub> = 10V	5	6	7	V
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0V	—	—	80	μA
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	T <sub>j</sub> = 25°C	—	1.95	2.55	V
		T <sub>j</sub> = 25°C	—	2.05	2.80	
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = -10V	—	—	200	nF
C <sub>oes</sub>	Output capacitance	V <sub>GE</sub> = 0V	—	—	10	nF
C <sub>res</sub>	Reverse transfer capacitance	V <sub>GE</sub> = 0V	—	—	6	nF
Q <sub>G</sub>	Total gate charge	V <sub>CC</sub> = 600V, I <sub>C</sub> = 600A, V <sub>GE</sub> = 15V	—	6600	—	nC
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> = 600V, I <sub>C</sub> = 600A V <sub>GE1</sub> = V <sub>GE2</sub> = 15V	—	—	450	ns
t <sub>r</sub>	Turn-on rise time		—	—	200	ns
t <sub>d(off)</sub>	Turn-off delay time		—	—	800	ns
t <sub>f</sub>	Turn-off fall time		—	—	300	ns
t <sub>rr</sub> (Note 1)	Reverse recovery time	RG = 1.0Ω, Inductive load switching operation I <sub>E</sub> = 600A	—	—	500	ns
Q <sub>rr</sub> (Note 1)	Reverse recovery charge		—	43.2	—	μC
V <sub>EC</sub> (Note 1)	Emitter-collector voltage	I <sub>E</sub> = 600A, V <sub>GE</sub> = 0V	—	—	3.35	V
R <sub>th(j-c)Q</sub>	Thermal resistance <sup>*1</sup>	IGBT part (1/2 module)	—	—	0.081	°C/W
R <sub>th(j-c)R</sub>		FWDi part (1/2 module)	—	—	0.11	°C/W
R <sub>th(c-f)</sub>	Contact thermal resistance	Case to fin, Thermal compound applied <sup>*2</sup> (1/2 module)	—	0.010	—	°C/W
R <sub>th(j-c)Q</sub>	Thermal resistance <sup>*3</sup>	T <sub>c</sub> measured point is just under the chips	—	—	0.032	°C/W
R <sub>G</sub>	External gate resistance		1.0	—	5.2	Ω

Note 1. I<sub>E</sub>, V<sub>EC</sub>, t<sub>rr</sub>, Q<sub>rr</sub> & die/dt represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).

2. Pulse width and repetition rate should be such that the device junction temp. (T<sub>j</sub>) does not exceed T<sub>jmax</sub> rating.

3. Junction temperature (T<sub>j</sub>) should not increase beyond 150°C.

4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

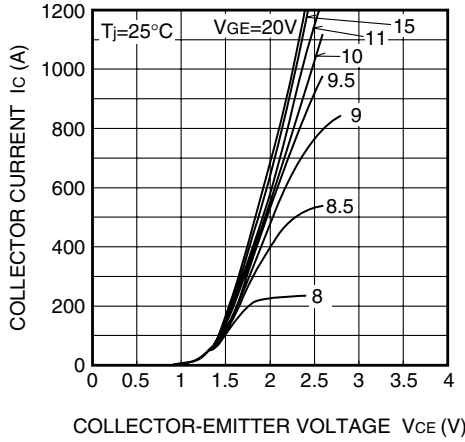
\*1 : T<sub>c</sub> measured point is indicated in OUTLINE DRAWING.

\*2 : Typical value is measured by using Shin-etsu Silicone "G-746".

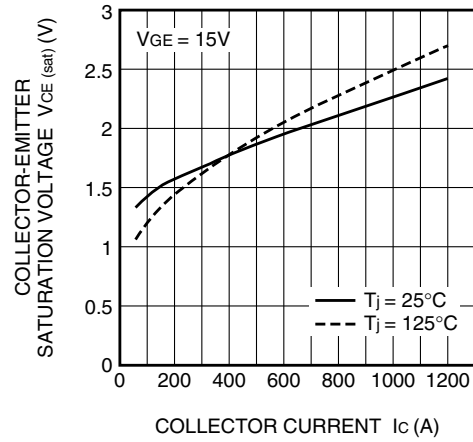
\*3 : If you use this value, R<sub>th(f-a)</sub> should be measured just under the chips.

PERFORMANCE CURVES

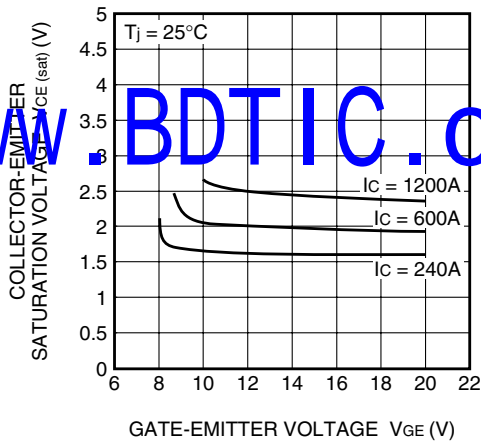
OUTPUT CHARACTERISTICS (TYPICAL)



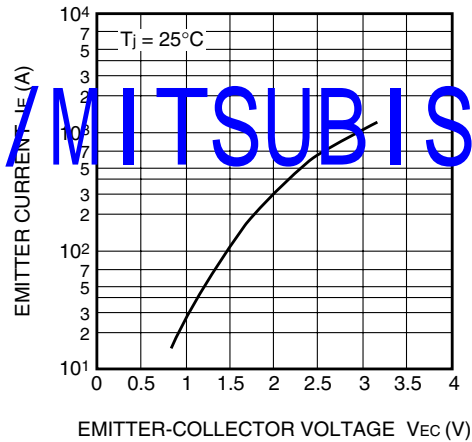
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



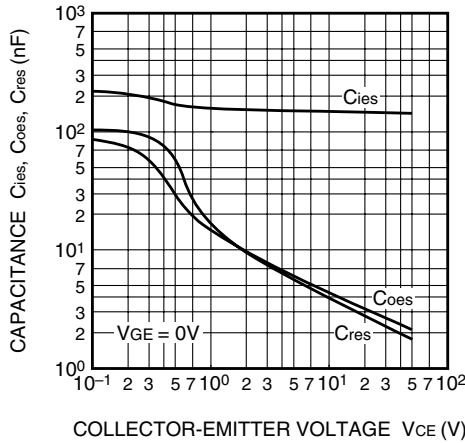
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



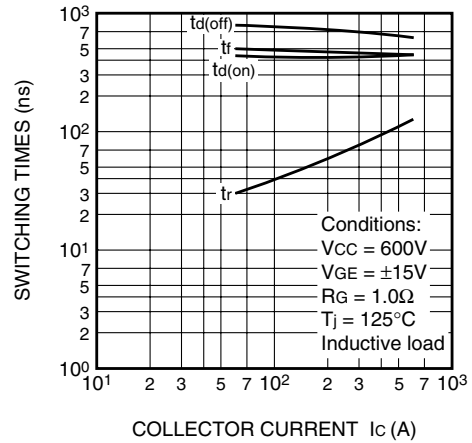
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



CAPACITANCE- $V_{ce}$  CHARACTERISTICS (TYPICAL)

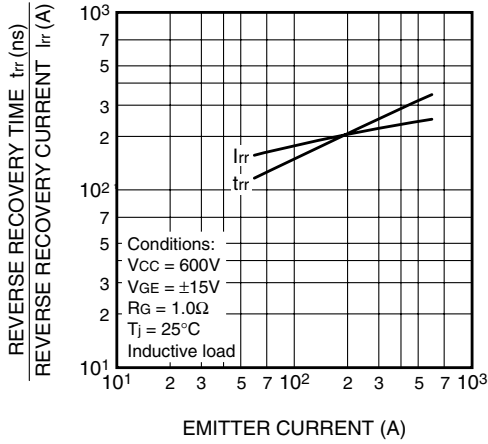


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

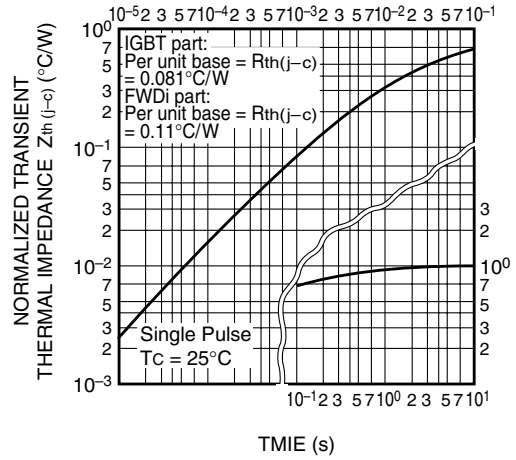


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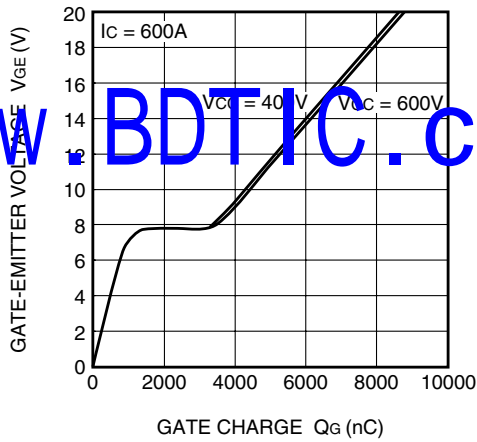
REVERSE RECOVERY CHARACTERISTICS OF FREE-WHEEL DIODE (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (IGBT part & FWDi part)



GATE CHARGE CHARACTERISTICS (TYPICAL)



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